

Notice of References Cited	Application/Control No. 10/527,802		Applicant(s)/Patent Under Reexamination OISHI, TERUHIKO	
	Examiner Ana M. Fortuna		Art Unit 1797	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,153,473	12-2006	Ericson et al.	422/44
*	B	US-4,906,375	03-1990	Heilmann, Klaus	210/500.23
*	C	US-4,789,733	12-1988	Winkelman, Lowell	530/383
*	D	US-6,165,363	12-2000	Oishi et al.	210/500.23
*	E	US-7,087,168	08-2006	Oishi et al.	210/500.23
*	F	US-5,938,929	08-1999	Shimagaki et al.	210/645
*	G	US-6,074,718	06-2000	Puglia et al.	428/36.5
*	H	US-5,762,798	06-1998	Wenthold et al.	210/500.23
*	I	US-5,683,584	11-1997	Wenthold et al.	210/500.23
*	J	US-5,340,480	08-1994	Kawata et al.	210/500.23
*	K	US-5,232,597	08-1993	Eguchi, Tamiyuki	210/500.23
*	L	US-4,882,223	11-1989	Aptel et al.	428/398
*	M	US-3,871,950	03-1975	Hashino et al.	428/398

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	V					
	W					
	X					

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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